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Application No.	Applicant(s)	
10/045,591	KOHN ET AL.	
Examiner	Art Unit	_
Denise Tran	2186	

SEARCHED				
Class	Subclass	Date	Examiner	
711	144- 145,159,1 33- 134,150- 152,3,	3/11/2005	DT	
	154-155,		DT	
	158,168		DT	
	140-141		DT	
	156,163		DT	
710	200,240		DT	
713	400		DT	
365	195-196	3/11/2005	DT	
709	400,248,	3/10/2005	DT	
	226		DT	
712	200,203		DT	
	225-229	3/11/2005	DT	

INT	NTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
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SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
East (USPGPUB,USPAT,USOCR,EPO,JP O,DERWENT,IBMTDB)	3/11/2005	DT
IEEE	3/10/2005	DT
East (USPGPUB,USPAT,USOCR,EPO,JP O,DERWENT,IBMTDB)	3/10/2005	DT
Inventor Names Search (East and Palm)	3/10/2005	DT